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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/813,989	DAVIS ET AL.	
Examiner	Art Unit	_
Alan S Chen	2182	

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Class	Subclass	Date	Examiner
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(EAST) USPAT; USPGPUB; EPO; JPO; IBM_TDB; DERWENT PLUS; Inventor Search	11/21/200Ġ	ASC
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